

Search Notes

Application/Control No.

10/656,055

Examiner

Ja-Na Hines

Applicant(s)/Patent under
Reexamination

YAYER ET AL.

Art Unit

1645

SEARCHED

Class	Subclass	Date	Examiner
424	9.2, 94.1, 116, 278.1	2/6/2006	JAH
435	4, 7.2		
	7.31,		
	7.32, 7.4		
	7.95, 32		
	71.3, 243		
	244,		
	252.1		
	254.1		
	255.1		
436	2		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STIC, west, deerwent, biosis, argicola, caplus, japiom eplus, scisearch, medline, biotechno, commerical databases, inventor	2/6/2006	JAH